Power MOSFET

30 V, 51 A, Single N-Channel, TO-220AB

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Low RG
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Power Motor Control
- High Current, High Side Switching
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Para	ameter		Symbol	Value	Unit
Drain-to-Source Vol	Drain-to-Source Voltage			30	V
Gate-to-Source Vol	Gate-to-Source Voltage			±20	V
Continuous Drain		$T_A = 25^{\circ}C$	I _D	12.8	Α
Current R _{θJA} (Note 1)		T _A = 85°C	1	9.9	
Power Dissipation R _{θJA} (Note 1)		T _A = 25°C	P _D	3.75	W
Continuous Drain		T _A = 25°C	ID	10.2	Α
Current $R_{\theta JA}$ (Note 2)	Steady	T _A = 85°C	1	7.9	
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T _A = 25°C	P _D	2.40	W
Continuous Drain		$T_C = 25^{\circ}C$	I _D	51	Α
Current R _{θJC} (Note 1)		T _C = 85°C		39.5	
Power Dissipation R _{θJC} (Note 1)		T _C = 25°C	P _D	60	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	154	Α
Current Limited by P	ackage	T _A = 25°C	I _{DmaxPkg}	95	Α
Operating Junction a Temperature	Operating Junction and Storage Temperature			-55 to +175	°C
Source Current (Bod	Source Current (Body Diode)			50	Α
Drain to Source dV/dt			dV/dt	6	V/ns
Single Pulse Drain–to–Source Avalanche Energy (V_{DD} = 24 V, V_{GS} = 10 V, I_L = 18 A_{pk} , L = 0.3 mH, R_G = 25 Ω)			EAS	48.6	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

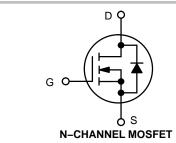
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



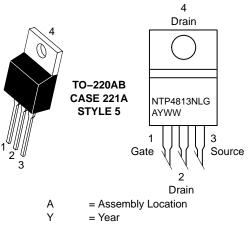
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	13.1 mΩ @ 10 V	51 A
30 V	22 mΩ @ 4.5 V	JIA



MARKING DIAGRAM & PIN ASSIGNMENT



WW = Work Week

G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	40	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	62.5	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				24.5		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	T _J = 25 °C			1	
		V _{DS} = 24 V	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)	•						-
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 20 A		10.5	13.1	
		V _{GS} = 4.5 V	I _D = 20 A		17.6	22	mΩ
Forward Transconductance	9FS	V _{DS} = 15 V, I _D = 10 A			6.7		S
Gate Resistance	R _G	T _A = 25	°C		0.80		Ω
CHARGES AND CAPACITANCES	•						
Input Capacitance	C _{ISS}				895		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 12 V			220		pF
Reverse Transfer Capacitance	C _{RSS}				120		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			7.7	10.8	nC
Threshold Gate Charge	Q _{G(TH)}				1.6		
Gate-to-Source Charge	Q _{GS}				3.4		
Gate-to-Drain Charge	Q_{GD}				3.6		1
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 11.5 \text{ V}, V_{DS} = 15 \text{ V};$ $I_D = 30 \text{ A}$			17		nC
SWITCHING CHARACTERISTICS (Note	4)						
Turn-On Delay Time	t _{d(ON)}				10		
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_{D} = 15 \text{ A},$ $R_{G} = 3.0 \Omega$			21.5		ns
Turn-Off Delay Time	t _{d(OFF)}				12		
Fall Time	t _f				3.2		
Turn-On Delay Time	t _{d(ON)}	$V_{GS} = 11.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			6.3		
Rise Time	t _r				13.4		1
Turn-Off Delay Time	t _{d(OFF)}				17.6		ns
Fall Time	t _f				1.6		1

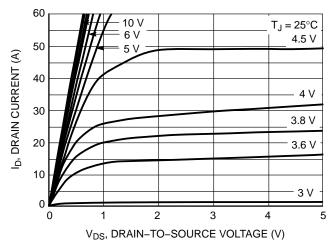
- 3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS								
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V$	T _J = 25°C		0.95	1.2		
		$V_{GS} = 0 \text{ V},$ $I_{S} = 30 \text{ A}$	T _J = 125°C		0.85		V	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dls/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			14.8			
Charge Time	ta				8.3		ns	
Discharge Time	t _b				6.5			
Reverse Recovery Charge	Q_{RR}				5.3		nC	

^{3.} Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 4. Switching characteristics are independent of operating junction temperatures.

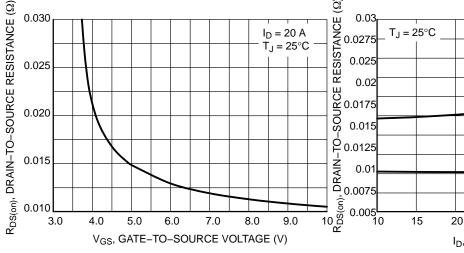
TYPICAL PERFORMANCE CURVES



60 $V_{DS} \ge 10 \text{ V}$ 50 ID, DRAIN CURRENT (A) 40 30 20 $T_J = 125^{\circ}C$ $T_J = 25^{\circ}C$ 10 $T_J = -55^{\circ}C$ 0 2 4 5 7 3 6 VGS, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



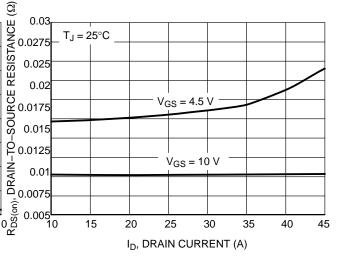
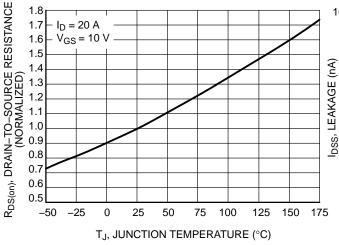


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



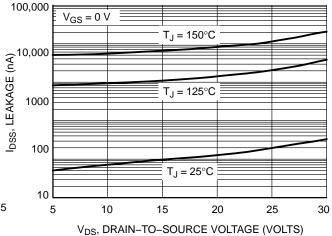
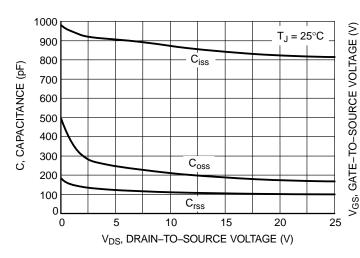


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

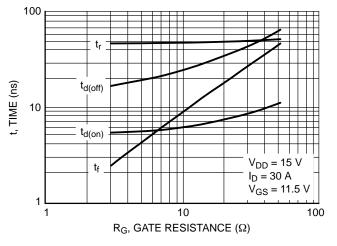
TYPICAL PERFORMANCE CURVES



15 13.5 Q_T 12 10.5 9 7.5 6 Q_2 Q_1 4.5 $I_D = 30 A$ 3 $V_{DD} = 15 V$ $V_{GS} = 11.5 \text{ V}$ 1.5 $T_J = 25^{\circ}C$ 0 5 6 7 8 9 10 11 12 13 14 15 16 Q_G, TOTAL GATE CHARGE (nC)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



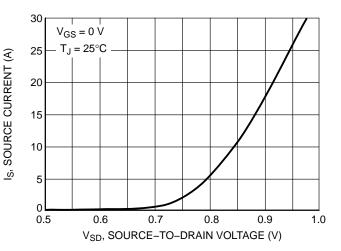
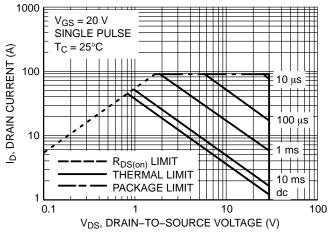


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



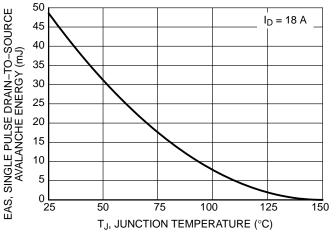


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

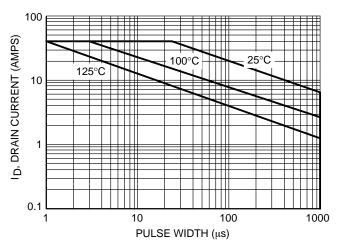


Figure 13. Avalanche Characteristics

ORDERING INFORMATION

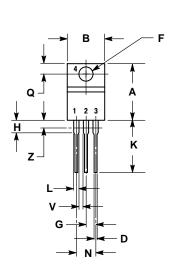
Device	Package	Shipping [†]
NTP4813NLT4G	TO-220AB (Pb-Free)	50 Units / Rail

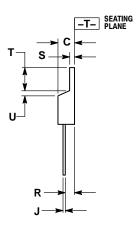
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

TO-220, SINGLE GAUGE

CASE 221A-09 **ISSUE AH**





- DIMENSIONING AND TOLERANCING PER ANSI
 - CONTROLLING DIMENSION: INCH
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.415	9.66	10.53
С	0.160	0.190	4.07	4.83
D	0.025	0.038	0.64	0.96
F	0.142	0.161	3.61	4.09
G	0.095	0.105	2.42	2.66
Н	0.110	0.161	2.80	4.10
J	0.014	0.024	0.36	0.61
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 5:

- GATE
- 2 DRAIN
- SOURCE 3.

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